













个区域的灰度值均大于理想值,因而使用它来分析我们的实验数据还是较为满意的。

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## The Gray Scale Fidelity of Images Retrieved from Holograms in Photorefractive Crystals

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**Abstract** In this paper, a new quantity, normalized nonlinear error (NNE) is proposed for the first time to our knowledge for the estimation of the gray scale fidelity of images retrieved from volume holograms stored in photorefractive Fe·LiNbO<sub>3</sub> crystals. Based on this, the dependence of gray scale fidelity on recording object-reference beam ratios is experimentally investigated, and the results agree well with theoretical predictions. The dynamic evolution of the normalized nonlinear error during hologram recording is also studied. The results show that a satisfactory gray scale fidelity can be obtained as long as the recording beam ratio is carefully chosen, even if the recording time is short, hence the diffraction efficiency is quite low.

**Key words** the gray scale fidelity, normalized nonlinear error (NNE), the recording object-reference beam ratio, recording time, diffraction efficiency